

Notice of References Cited	Application/Control No. 10/069,004	Applicant(s)/Patent Under Reexamination ARAMAKI, TAKASHI	
	Examiner Nguyen Ngo	Art Unit 2616	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,577,609	06-2003	Sharony, Jacob	370/312
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/069,004	Applicant(s)/Patent Under Reexamination ARAMAKI, TAKASHI	
	Examiner Nguyen Ngo	Art Unit 2663	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0012352	01-2002	Hansson et al.	370/401
*	B	US-5,889,777	03-1999	Miyao et al.	370/395.52
*	C	US-6,484,209	11-2002	Momirov, Milan	709/238
*	D	US-6,563,830	05-2003	Gershon et al.	370/395.53
*	E	US-6,477,149	11-2002	Okanoue, Kazuhiro	370/312
*	F	US-7,012,931	03-2006	Higuchi et al.	370/467
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(e).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/069,004	Applicant(s)/Patent Under Reexamination ARAMAKI, TAKASHI	
	Examiner Binh Q. Nguyen	Art Unit 2664	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,683,866	01-2004	Stanwood et al.	370/350
	B	US-2004/0213197	10-2004	Zimmerman et al.	370/346
	C	US-6,956,834	10-2005	Stanwood et al.	370/329
	D	US-6,246,696	06-2001	Yamaguchi et al.	370/475
	E	US-6,567,418	05-2003	Chuah, Mooi Choo	370/418
	F	US-6,628,629	09-2003	Jorgensen, Jacob W.	370/322
	G	US-6,771,660	08-2004	Bourlas et al.	370/466
	H	US-6,785,252	08-2004	Zimmerman et al.	370/337
	I	US-2002/0099854	07-2002	JORGENSEN, JACOB W.	709/249
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.